

<b>Notice of References Cited</b>	Application/Control No. 10/042,142		Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner Alicia Baturay		Art Unit 2146	Page 1 of 5

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<b>Notice of References Cited</b>	Application/Control No. 10/042,142		Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner Alicia Baturay		Art Unit 2146	Page 2 of 5

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<b>Notice of References Cited</b>	Application/Control No. 10/042,142		Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner Alicia Baturay		Art Unit 2146	Page 3 of 5

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<b>Notice of References Cited</b>	Application/Control No. 10/042,142		Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner Alicia Baturay		Art Unit 2146	Page 4 of 5

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	Examiner Alicia Baturay		Art Unit 2146	Page 5 of 5

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